

Notice of References Cited

Application/Control No.

10/050,020

Applicant(s)/Patent Under
Reexamination
SMITH ET AL.

Examiner

Rip A. Lee

Art Unit

1713

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0016406 A1	02-2002	Chen et al.	524/502
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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